

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14219-068US1	Application No. 10/511820
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Lutz Kirsten	
		Filing Date	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	US2004/0121179	06/24/04	Lutz Kirsten			
	AB	4,425,556	01/10/84	Leopold Hanke et al			
	AC	5,879,812	03/09/99	Toshiki Nishiyama et al			
	AD	4,254,070	03/03/81	Masatada Yodogawa et al.			
	AE	6,320,738	11/20/01	Tsuyoshi Yamana et al			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	101 20 517	11/21/02	Germany			Abstract	
	AM	196 22 690	12/12/96	Germany			Abstract	
	AN	29 44 029	04/14/88	Germany			Abstract	
	AO	100 53 769	05/10/01	Germany			Abstract	
	AP	0 040 391	11/25/81	EPO			Abstract	
	AQ	0 974 982	01/26/00	EPO			Abstract	
	AR	1,186,116	04/02/70	United Kingdom				
	AS	100 18 377	12/06/01	Germany			Abstract	
	AT	197 19 174	11/12/98	Germany			Abstract	

Other Documents (include Author, Title, Date, and Place of Publication)		
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